



Based on Form PTO-1449
(3/90)

LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

ATTY. DOCKET NO.
450100-03261

SERIAL NO.
09/894,689

APPLICANT
Shigeyoshi HIRASHIMA et al.

FILING DATE
June 27, 2001

GROUP
2182

U.S. PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
|---------------------|----|-----------------|----------|-----------------|-------|----------|-------------------------------|
| | AA | 6 041 183 | 03/21/00 | Hayafune et al. | | | |
| | AB | 5 897 607 | 04/27/99 | Jerney et al. | | | |
| | AC | | | | | | |
| | AD | | | | | | |
| | AE | | | | | | |
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FOREIGN PATENT DOCUMENTS

| | | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION YES NO |
|--|----|-----------------|----------|---------|-------|----------|-----------------------|
| | AL | EP 0 873 873 | 10/28/98 | Europe | | | |
| | AM | | | | | | |
| | AN | | | | | | |
| | AO | | | | | | |
| | AP | | | | | | |

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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|---------------------|----|-----------------|----------|------------------|-------|----------|-------------------------------|
| | AA | 5 930 553 | 07/27/99 | Hirst et al. | | | |
| | AB | 5 786 828 | 07/28/98 | Yamamoto | | | |
| | AC | 5 519 418 | 05/21/96 | Nishikawa et al. | | | |
| | AD | | | | | | |
| | AE | | | | | | |
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